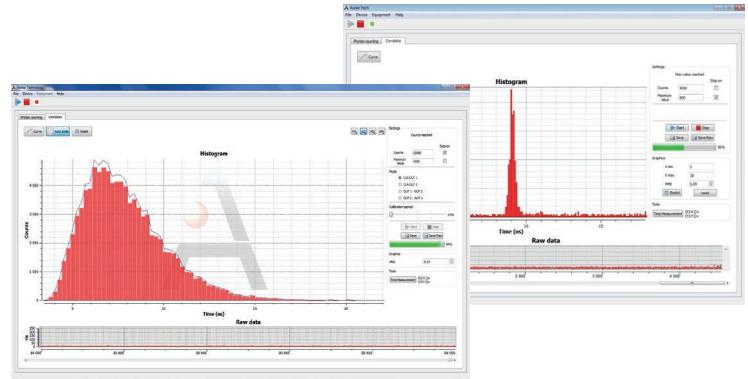


PICOXEA

TCSPC Instrument

Fully-integrated TCSPC, photon counter & ps laser
[405 nm - 1680 nm]



Engineered with "high-performance and ease-of-use" innovative mindset, the PICOXEA instrument fully integrates within the same box, the world's most advanced photon detectors based on Geiger-mode avalanche photodiode technology, up to two high-performance picosecond laser sources and time correlation electronics.

The PICOXEA instrument is the new generation of self-contained instrument that brings a breakthrough in high-resolution OTDR measurements, lifetime measurements and FLIM microscopy. **A wide range of emission wavelengths as well as two types of photon detectors for low-level-of-light detection in the visible (400 nm - 1060 nm) or in the NIR range (900 nm - 1700 nm) are available.**

Very well-designed, its modern interfaces and high-performances make the PICOXEA an essential and complete analytic tool for any time-resolved measurements !

Features

- High-performance ps laser source
- Time resolved electronics
- NIR & VIS photon counter
- User friendly graphical interface
- Remote control
- DLL Libraries : LabVIEW, C++
- Read out in TTL

Applications

- High-resolution reflectometry
- TCSPC measurements
- Lifetime measurements
- FLIM microscopy
- Optical fiber sensing

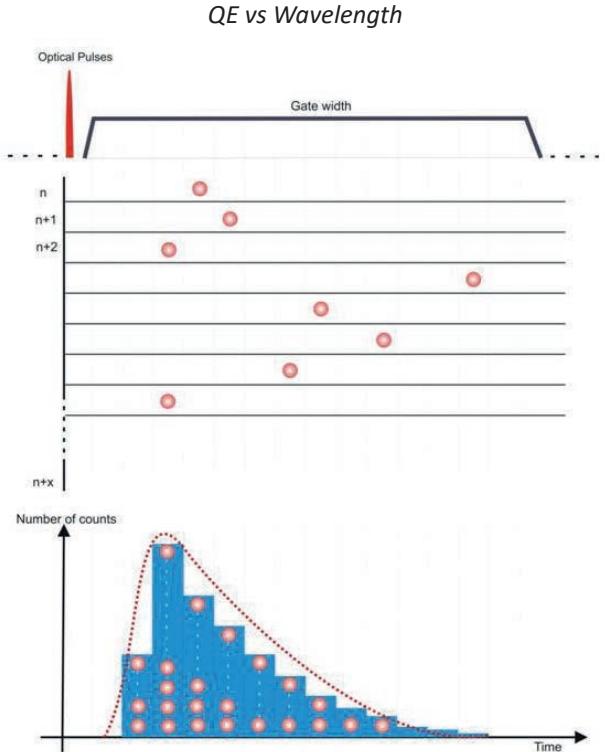
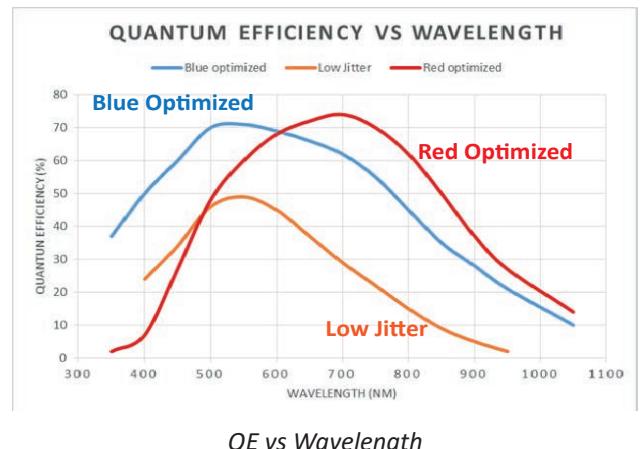
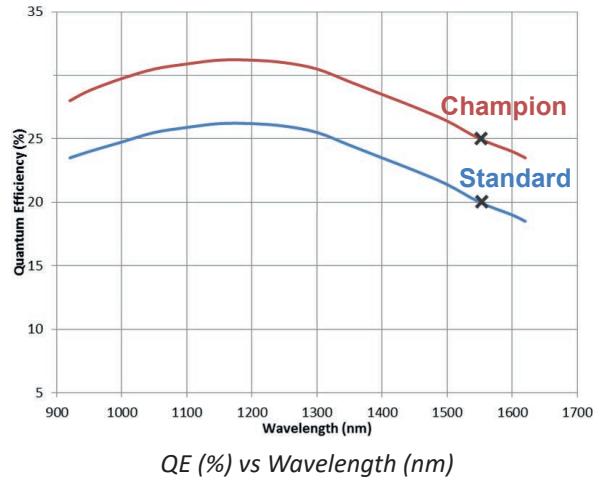
Options

- 2 detection channels
- 2 emission channels

TECHNICAL SPECIFICATIONS

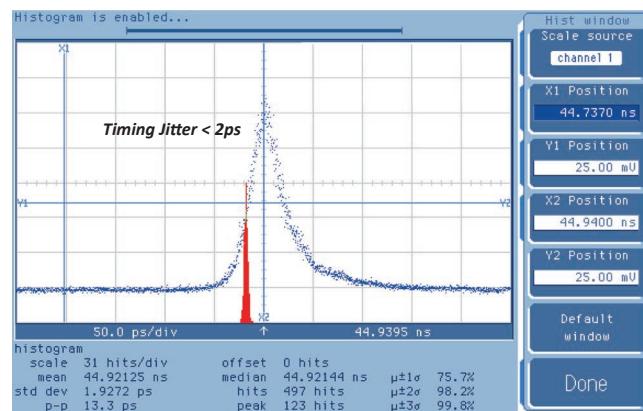
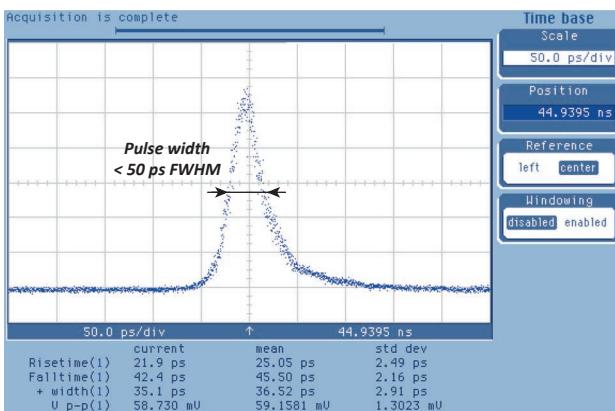
Picosecond laser emission	
Wavelength	From 405 nm to 1680 nm (see table 1)
Optical pulse width	From 45 ps to 80 ps typical (see table 1)
Peak power	Adjustable up to 250 mW (see table 1)
Max repetition rate	20 MHz
Continuous wave	Continuous wave operation (option)
NIR photon detection	
Detector type	InGaAs Geiger mode APD
Spectral range	900 nm to 1700 nm
Dark Count Rate @10% QE	< 5 000 cps : standard grade < 1 000 cps : champion grade
Quantum Efficiency	10% - 25% [5% step] : standard grade 10% - 30% [10% step] : champion grade
Timing Jitter @max QE	< 200 ps
Min deadtime	1 µs
Visible photon detection	
Detector type	Silicon Geiger mode APD
Wavelength	400 nm - 1060 nm
Dark Count Rate	< 100 cps
Quantum Efficiency	> 60% [550 nm - 700 nm]
Timing Jitter @max QE	< 350 ps (< 50 ps)
Min deadtime	20 ns - 40 ns
Synchronization	
External trigger	From CW up to 20 MHz
Internal trigger	From CW up to 20 MHz
Time Correlation	
Timing resolution	65 ps from 0 to 400 ns measurement range 60 ns from 400 ns up to 1 ms measurement range
Data transfert	0.25 Million of correlation per sec
Data display	Graphical User Interface Histograms & curves Raw data & DLL libraries
Input/Output - Mechanical - Environmental	
Computer Connection	Mini USB 2.0 type B
Optical In	FC/PC optical fiber connector
Detection Out	SMA female type connector (TTL)
Clock In	SMA female type connector (TTL)
Clock Out	SMA female type connector (TTL)
Power consumption	5 W
Dimensions (LxWxH)	70 x 250 x 280 mm ³
Weight	4.5 kg
Operating temperature	+ 10°C to + 30°C
Cooling time	< 1 min @ 25°C

¹ per 10ns measurement time @10µs deadtime and 10% QE

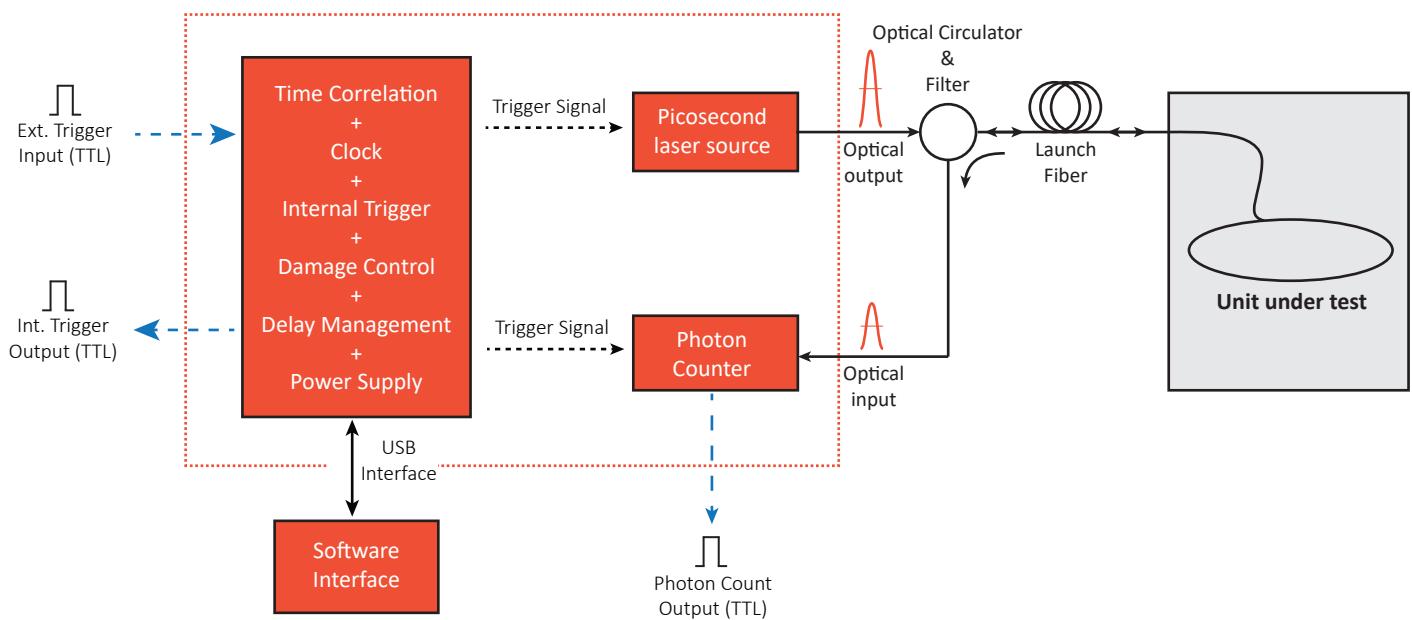


Time histogram building representation

PERFORMANCES



APPLICATION EXAMPLE - OTDR measurements



ORDERING INFORMATION

PICOXEA_LASXXX_Y_ZZZ_00

XXX Laser wavelength
Y : Pulsed mode only
D : Dual pulsed & CW operation

NIR_S: Near-infrared detection Standard
NIR_C: Near-infrared detection Champion
VIS_B: Visible detection blue optimized
VIS_R: Visible detection red optimized
VIS_LJ: Visible detection low jitter optimized

00: FC/APC laser output & FC/PC detector input
Other type on request

Please contact us for custom solutions and options

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